

Notice of References Cited

Application/Control No.

10/581,060

Applicant(s)/Patent Under
Reexamination
KAWAKUBO ET AL.

Examiner

Christina Riddle

Art Unit

4175

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,833,621 A	05-1989	Umatate, Toshikazu	700/101
*	B	US-5,525,808 A	06-1996	Irie et al.	250/548
*	C	US-5,585,925 A	12-1996	Sato et al.	356/401
*	D	US-5,805,866 A	09-1998	Magome et al.	716/19
*	E	US-5,808,910 A	09-1998	Irie et al.	700/279
*	F	US-6,239,858 B1	05-2001	Tomimatu, Yoshikatu	355/18
*	G	US-2001/0034563 A1	10-2001	Matsumoto et al.	700/101
*	H	US-6,338,925 B1	01-2002	Tomimatu, Yoshikatu	430/30
*	I	US-2002/0042664 A1	04-2002	Kikuchi, Takahisa	700/114
*	J	US-2002/0111038 A1	08-2002	Matsumoto et al.	438/763
*	K	US-2004/0126004 A1	07-2004	Kikuchi, Takahisa	382/141
*	L	US-6,992,767 B2	01-2006	Matsumoto et al.	356/401
*	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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